

Notice of References Cited	Application/Control No. 10/823,729	Applicant(s)/Patent Under Reexamination WATANABE ET AL.	
	Examiner DAVID VU	Art Unit 2818	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,001,706	12-1999	Tan et al.	438/424
*	B	US-6,638,866	10-2003	Cheng et al.	438/692
*	C	US-6,046,112	04-2000	Wang, Ying-Lang	438/693
*	D	US-6,171,180	01-2001	Koutny et al.	451/287
*	E	US-6,677,239	01-2004	Hsu et al.	438/692
*	F	US-5,861,054	01-1999	Miyashita et al.	106/3
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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